

**Search Notes**

Application/Control No.

10/576,769

Examiner

Rita Leykin

Applicant(s)/Patent under  
Reexamination

HIKAWA ET AL.

Art Unit

2837

**SEARCHED**

Class	Subclass	Date	Examiner
318	471	2/16/2007	R.L.
	806		
	490		
361	29		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPAT, DERWENT, EPO, JPO, USPGPUB	2/16/2007	R.L.